

HID GLOBAL CORPORATION

MULTICLASS

Model: RP40D-6408-300

22 October 2008 Report No.: SL08080401-HID-014-RP40D-6408-300 (15.225 & RSS-210) (This report supersedes NONE)



Modifications made to the product : None			
This Test Report is Issued Under the Authority of:			
Snall Leng	Buis		
Snell Leong	Leslie Bai		
Test Engineer	Engineering Reviewer		

This test report may be reproduced in full only. Test result presented in this test report is applicable to the representative sample only.



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SIEMIC ACREDITATION DETAILS: NVLAP Lab Code: 200729-0



NVLAP-01C (REV. 2006-09-13)



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SIEMIC ACREDITATION DETAILS: A2LA Certificate Number: 2742.01





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SIEMIC ACREDITATION DETAILS: FCC Registration No. 783147

FEDERAL COMMUNICATIONS COMMISSION

Laboratory Division 7435 Oakland Mills Road Columbia, MD 21046

December 20, 2007

Registration Number: 783147

SIEMIC Laboratories 2206 Ringwood Avenue, San Jose, CA 95131

Attention: Leslie Bai

Re: Measurement facility located at San Jose 3 & 10 meter site Date of Renewal: December 20, 2007

Dear Sir or Madam:

Your request for renewal of the registration of the subject measurement facility has been received. The information submitted has been placed in your file and the registration has been renewed. The name of your organization will remain on the list of facilities whose measurement data will be accepted in conjunction with applications for Certification under Parts 15 or 18 of the Commission's Rules. Please note that the file must be updated for any changes made to the facility and the registration must be renewed at least every three years.

Measurement facilities that have indicated that they are available to the public to perform measurement services on a fee basis may be found on the FCC website <u>www.fcc.gov</u> under E-Filing, OET Equipment Authorization Electronic Filing, Test Firms.

Sincerely,

Phyllis Parrish Industry Analyst



Accessing global markets RF Test Report of HID Global Corporation Model : RP40D-6408-300 FCC 15.225 2008, RSS-210 Issue 7 : 2007

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SIEMIC ACREDITATION DETAILS: Industry of Canada Registration No. 4842-1

Industry Industrie Canada Canada

May 23rd, 2008

OUR FILE: 46405-4842 Submission No: 126429

Siemic Inc. 2206 Ringwood Ave. San Jose CA 95131 USA

Attention: Leslie Bai

Dear Sir/Madame:

The Bureau has received your application for the registration / renewal of a 3/10m OATS. Be advised that the information received was satisfactory to Industry Canada. The following number(s) is now associated to the site(s) for which registration / renewal was sought (4842A-1). Please reference the appropriate site number in the body of test reports containing measurements performed on the site. In addition, please be informed that the Bureau is now utilizing a **new site numbering scheme** in order to simplify the electronic filing process. Our goal is to reduce the number of secondary codes associated to one particular company. The following changes have been made to your record.

- Your primary code is: 4842

- The company number associated to the site(s) located at the above address is: 4842A

- The table below is a summary of the changes made to the unique site registration number(s):

New Site	Obsolete Site	Description of Site	Expiry Date
Number	Number		(YYYY-MM-DD)
4842A-1	4842-1	3m Chamber	2010-05-23

Furthermore, to obtain or renew a unique site number, the applicant shall demonstrate that the site has been accredited to ANSI C63.4-2003 or later. A scope of accreditation indicating the accreditation by a recognized accreditation body to ANSI C63.4-2003 shall be accepted. Please indicate in a letter the previous assigned site number if applicable and the type of site (example: 3 meter OATS or 3 meter chamber). If the test facility is not accredited to ANSI C63.4-2003 or later, the test facility shall submit test data demonstrating full compliance with the ANSI Standard. The Bureau will evaluate the filing to determine if recognition shall be granted.

The frequency for re-validation of the test site and the information that is required to be filed or retained by the testing party shall comply with the requirements established by the accrediting organization. However, in all cases, test site re-validation shall occur on an interval not to exceed two years. There is no fee or form associated with an OATS filing. OATS submissions are encouraged to be submitted electronically to the Bureau using the following URL; http://strategis.ic.gc.ca/epic/internet/inceb-bhst.nsf/en/h_tt00052e.html.

If you have any questions, you may contact the Bureau by e-mail at <u>certification.bureau@ic.gc.c</u> Please reference our file and submission number above for all correspondence.

Yours sincerely,

a,

S. Proulx Test & Measurement Specialist Certification and Engineering Bureau 3701 Carling Ave., Building 94 Ottawa, Ontario K2H 8S2



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SIEMIC ACREDITATION DETAILS: Japan VCCI Registration No. 2195

	1/61
	Voluntary Control Council for Interference by Information Technology Equipment 7F NOA Bidg, 2-3-5, Azabudai, Minato-Ku, Tokyo, Japan, 108–0041 Tet+81-3-5575-3138 Fac+81-3-5575-3137 http://www.vocior.jp
	February 12 , 2004
TO: SIEMIC, INC.	
Membership NO: 2195	
We confirmed your payment for annual member you very much for your remitting.	rship fee and admission fee. Thank
Please find enclosed VCCI documents. As adm were confirmed, your company registered as V	
From now on, it is possible for your company to or/and application for registration of measurem	o submit conformity verification report nent facilities.
Please find necessary forms for your submission www.vcci.or.jp	on from VCCI web-site.
When you submit conformity verification report inagaki@vcci.or.jp and application for registratic submit to Mr. Masaru Denda / denda@vcci.or.jp	on of measurement facilities, please
Their address, phone and fax number are absol indicated on top right-hand corner of this page	
If you have any other questions regarding mem Thank you very much.	bership, feel free to contact me.
Best Regards,	
Naoko Hori (Ms.) VCCI hori®veci.or.jp	
Enclosure	
情報処理装置等電波障害自主	:規制協議会 (略称VCCI) MOAビル) 7階 Tel-03-5575-3138-Fas:03-5575-3137



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SIEMIC ACREDITATION DETAILS: Japan RF Technologies Accreditation No. MRF050927





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SIEMIC ACREDITATION DETAILS: Korea MIC Lab Code: KR0032

C	험기관지정서 Certificate Designated Testing Laboratory
지정변호(No.) :	KR0032
시험기관명	: (주)현대교정인중기술원
Name of Lab.)	(Hyundai Calibration & Certification Technologies Co., Ltd)
÷ ± ÷	: 경기도 이천시 부발음 아미리 산136-1
Address)	(136-1, Ami-ri, Bubal-eup, Ichean-si, Kiunggi-Do, Korea)
	2206 Ringwood Avenue San Jose, CA, USA.
시험분야 및 범위 :	유선(Telecommunication Part)
Area & Category)	무선(Radio Communication Part) 전자과장대(EMI) : 미국지사 포함
	진자파내성(EMS) : 미국지사 포함
	전기 안전 (Safety)
	전자과흡수율(SAR)
	통신기기시험기관지정및관리등에관한규칙에 보통신기기시험기관으로 지정합니다. This is to certify that
the abou	e mentioned laboratory is designated
	esting laboratory in accordance with
	ons on Designation of Testing Laboratory
2	005년(Year) 7월(Month) 5일(Dat 251006)
저	파연구소장
Director G Ministry	eneral of Radio Research Laboratory of Information and Communication Republic of Korea



SIEMIC, INC. Accessing global markets RF Test Report of HID Global Corpo

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SIEMIC ACREDITATION DETAILS: Korea CAB ID: US0160

		UNITED STATES DEPARTM National Institute of Stan Gaithersburg, Maryland 20899	dards and Technology
April 17, 2006			
Mr. Leslie Bai SIEMIC Laboratories 2206 Ringwood Avenue San Jose, CA 95131			
Dear Mr. Bai:			
I am pleased to inform you that yo Communication's Radio Research (APEC) Mutual Recognition Arra Conformity Assessment Body (C/ The pertinent information about y CAB Name: SIEMIC Laborator Identification No.: US0160 Scope:	h Laboratory (RRL) u ingement (MRA). Vo AB) under Appendix our faboratory's desi	inder the Asia Pacific Economic (our laboratory is now designated B, Phase I Procedures, of the AI	Cooperation to not as a
Coverage		Standards	Date of Recognition
Electro Magnetic Interference	RRL Notice No. 2005-82: Technical Requirements for Electromagnetic Interference Annex 8(KN-22), RRL Notice No. 2005-131: Conformity Assessment Procedure for Electromagnetic Interference		April 13, 2006
Electro Magnetic Susceptibility	I. RRL Notice No Requirements f Susceptibility Z. Annex 1–7(KN -4-6, -4-8, -4-1 Conformity As	5. 2005-130: Technical for Electromagnetic (-61000-4-2, -4-3, -4-4, -4-5, 1), RRL Notice No. 2005-132: sessment Procedure for ic Susceptibility	April 13, 2006
You may submit test data to RRL applicable requirements. The desi accreditation for the designated so The names of all recognized CAB have any questions please contact continued interest in our internatio Sincerely, David F. Alderman Group Leader, Standards Coordin	ignation of your orga cope remains valid an is will be posted on th Mr. Jogindar (Joe) E onal conformity asses	nization will remain in force as k ad comply with the designation re he NIST website at http://ts.nist.g bhillon at (301) 975-5521. We ap siment activities.	ong as its quirements. ov/mra. If you
cc: Jogindar Dhillon	and contraining	. strath	NIST
	and contenting	, droup	



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SIEMIC ACREDITATION DETAILS: Taiwan BSMI Accreditation No. SL2-IN-E-1130R

UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Geithersburg, Maryland 20899-May 3, 2006 Mr. Leslie Bai SIEMIC Laboratories 2206 Ringwood Avenue San Jose, CA 95131 Dear Mr. Bai: I am pleased to inform you that your laboratory has been recognized by the Chinese Taipei's Bureau of Standards, Metrology, and Inspection (BSMI) under the Asia Pacific Economic Cooperation (APEC) Mutual Recognition Arrangement (MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA. You may submit test data to BSMI to verify that the equipment to be imported into Chinese Taipei satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements. The pertinent designation information is as follows: SL2-IN-E-1130R (Must be applied to the test reports) BSMI number: U.S Identification No: US0160 Scope of Designation: CNS 13438 Authorized signatory: Mr. Leslie Bai . The names of all recognized CABs will be posted on the NIST website at http://ts.nist.gov/mra. If you have any questions, please contact Mr. Dhillon at 301-975-5521. We appreciate your continued interest in our international conformity assessment activities. Sincerely, Part & accu David F. Alderman Group Leader, Standards Coordination and Conformity Group Jogindar Dhillon digit. NIC



To

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SIEMIC ACREDITATION DETAILS: Taiwan NCC CAB ID: US0160

UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gethersburg, Maryland 20899-August 8, 2006 Mr. Leslie Bai SIEMIC Laboratories 2206 Ringwood Avenue San Jose, CA 95131 Dear Mr. Bai: am pleased to inform you that SIEMIC Laboratories has been recognized by the Chinese Taipei's National Communications Commission (NCC) under the Asia Pacific Economic Cooperation for Telecommunications and Information, Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA. You may submit test data to NCC to verify that the equipment to be imported into Chinese Taipei satisfies their applicable requirements using the following guidelines: Your laboratory's assigned 6-digit U.S. identification number is US0160. You should reference this number in your correspondence. The scope of designation is limited to LP0002. Your designation will remain in force as long as your accreditation remains valid for the scope of designation. If you have any questions please contact Mr. Jogindar Dhillon via email at dhillon@nist.gov or via fax at 301-975-5414. The names of all recognized laboratories will be posted on the NIST website at http://ts.nist.gov/mra. We appreciate your continued interest in our international conformity assessment activities. Sincerely, 2 ach David F. Alderman Group Leader, Standards Coordination and Conformity Group 000 Jogindar Dhillon NIST



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SIEMIC ACREDITATION DETAILS: Mexico NOM Recognition

Laboratorio Valentín V. Rivero CANIETI CAMARA NACIONAL BE LA INDUSTRIA ELECTRONOL DE TEL ECOMUNICACIONES E INFORMATICA México D.F. a 16 de octubre de 2006. LESLIE BAI DIRECTOR OF CERTIFICATION SIEMIC LABORATORIES, INC. ACCESSING GLOBAL MARKETS PRESENTE En contestación a su escrito de fecha 5 de septiembre del año en curso, le comento que estamos muy interesados en su intención de firmar un Acuerdo de Reconocimiento Mutuo, para lo cual adjunto a este escrito encontrara el Acuardo en idioma ingles y espeñol prellenado de los cuales le pido sea revisado y en su caso corregido, para que si esta de acuerdo poder firmarlo para mandarto con las autoridades Mexicanas para su visto bueno y así poder ejercer dicho acuerdo. Aprovecho este escrito para mencionarle que nuestro intermediario gestor será la empresa Isatel de México, S. A. de C. V., empresa que ha colaborado durante mucho tiempo con nosotros en lo relacionado a la evaluación de la conformidad y que cuenta con amplia experiencia en la gestorla de la certificación de cumplimiento con Normas Oficiales Mexicanas de producto en México. Me despido de ustad enviêndole un cordial seludo y esperando sus comentarios al Acuerdo que nos poupa. Atentamente: Ing. Fausting-Bornez González Gerenite Teenico del Laboratorio de CANIER Culturile 11 Hadoromo Condexa Cento Marico, D.F. Tel: 5254-6308 con 12 lineas Fair 5254-0496 www.contleft.org



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SIEMIC ACREDITATION DETAILS: Hong Kong OFTA Recognition No. D23/16V

OFTA 電訊管理局	Your Ref 來商檔號: Our Ref 本局檔號:	Telephone 電話: (852) 2961 6320 Fax No 副文傳典: (852) 2838 5004 E-mail 電動地址: 20 July 2005
	Mr. Leslie Bai Director of Certification, SIEMIC Laboratories 2206 Ringwood Avenue San Jose, California 95131 USA	
	Dear Mr. Bai,	
	Application of Recognised Tes	ting Agency (RTA)
	Referring your submission of 28 June RTA, 1 am pleased to inform you that OFTA (SIEMIC) as a Recognised Testing Agency (RTA)	
	Please note that, under the Hong K Evaluation and Certification (HKTEC) Scheme evaluation tests on telecommunications equip specifications :	ong Telecommunications Equipment e, SIEMIC is authorized to conduct ment against the following HKTA
	Scope of recognition (HKTA Specifics 1001, 1002, 1004, 1006, 1007, 1008 1010, 1015, 1016 1022, 1026, 1027, 1029 1030, 1031, 1032, 1033, 1034, 1035, 1 1041, 1042, 1043, 1045, 1047, 1048 2001	
	You are requested to refer to and co guidelines for RTA as given in the Information N Agency (RTA) for Conducting Evaluation Test which can be downloaded from http://www.offa.gov.hk/tec/information-notes.html	of Telecommunications Equipment", n OFTA's homepage at
	If you have any queries, please do not	hesitate to contact me.
		Yours sincerely,
		(K K Sin) (K K Sin) for Director-General
	Office of the Telecommunications Authority	f Telecommunications http://www.ofta.gov.hk
	29/F Wu Chung House 213 Queen's Road East V 電 訊 管 理 局 香港湾行皇后大道東 213 蔡胡忠大康 29 字棲	tan Unar Hong Kong



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Model : RP40D-6408-300 FCC 15.225 2008, RSS-210 Issue 7 : 2007

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Executive Summary & EUT information 1

The purpose of this test programmed was to demonstrate compliance of the HID Global Corp., Model: RP40D-6408-300 against the current Stipulated Standards. The MultiCLASS Indala have demonstrated compliance with the FCC 15.207, 15.209, 15.225: 2008 and Canadian Standards RS-Gen Issue 2, RSS-210 issue 7 & RSS 310 issue 2.

HID Global Corp. is the applicant and claimed manufacturer of this tested product. For the detailed description of this product, please refer to the iCLASS User Manual submitted as another Exhibit to this application.

The equipment under test radio operating frequency is 125 kHz and 13.56 MHz.

The test has demonstrated that this unit complies with stipulated standards.

EUT Information			
EUT Description	:	The HID RP40D-6408-300 is an inductive proximity card reader intended to be used in access control systems, parking systems and other applications using RFID readers. It is capable of reading 125 kHz and 13.56 MHz inductive tags.	
Model No	:	RP40D-6408-300	
Serial No	:	N/A	
Input Power	:	12 VDC	
Classification Per Stipulated Test Standard	:	RFID Reader	



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TECHNICAL DETAILS 2

Purpose	Compliance testing of MultiCLASS with stipulated standard
Applicant / Client	HID Global Corporation
Manufacturer	HID Global Corporation 15730 Barranca Parkway Irvine, CA 92618 USA
Laboratory performing the tests	SIEMIC Laboratories
Test report reference number	SL08080401-HID-014-RP40D-6408-300 (15.225 & RSS-210)
Date EUT received	19 September 2008
Standard applied	47 CFR §15.207, 15.209, 15.255: 2008 & Canadian Standards RS-GEN Issue 2: 2007, RSS-210 Issue 7: 2007 & RSS-310 Issue 2: 2007
Dates of test (from – to)	23 September – 03 October 2008
No of Units:	1
Equipment Category:	DXX &DCD
Trade Name:	MultiCLASS
Model :	RP40D-6408-300
RF Operating Frequency (ies)	125 kHz and 13.56 MHz (RFID)
Number of Channels :	125 kHz (1) & 13.56 MHz (1)
Modulation :	125 kHz (PSK) & 13.56 MHz (AM)
FCC ID :	JQ6-MCLASS40D
IC ID :	2236B-ICLASS



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3 MODIFICATION

NONE



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4 TEST SUMMARY

The product was tested in accordance with the following specifications. All testing has been performed according to below product classification:

RFID Reader

Test Results Summary

Test Standard				
47 CFR Part 15.225: 2008	RSS 210 Issue 7: 2007 & RSS-310 Issue 2: 2007	Description Pass /		
15.203		Antenna Requirement	Pass	
15.207(a)	RSS Gen(7.2.2)	Conducted Emissions Voltage	Pass	
15.225(a)	RSS210(A2.6)	Limit in the band of 13.553 – 13.567 MHz	Pass	
15.225(b)	RSS210(A2.6)	Limit in the band of 13.410 – 13.553 MHz and 13.567 – 13.710 MHz	Pass	
15.225(c)	RSS210(A2.6)	Limit in the band of 13.110 – 13.410 MHz and 13.710 – 14.010 MHz	Pass	
15.225(d), 15.209	RSS210(A2.6)	Limit outside the band of 13.110 – 14.010 MHz	Pass	
15.225(e)	RSS210(A2.6)	Frequency Stability	Pass	
	RSS-210(5.9.1)	Occupied Bandwidth	Pass	
	RSS-310 (3.7)	Very Low Power Devices Operating Below 490 kHz	Pass	

PS: All measurement uncertainties are not taken into consideration for all presented test result.



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5 MEASUREMENTS, EXAMINATION AND DERIVED RESULTS

5.1 Antenna Requirement

Requirement(s): 47 CFR §15.203

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

Antenna requirement must meet at least one of the following:

- a) Antenna must be permanently attached to the device.
- b) Antenna must use a unique type of connector to attach to the device.
- c) Device must be professionally installed. Installer shall be responsible for ensuring that the correct antenna is employed with the device.
- 1) The RFID antenna is integral to the main board permanently to the device which meets the requirement. (See Internal photographs in Annex B.i.)



5.2 Conducted Emissions Voltage

Requirement(s): 47 CFR §15.207

Requirement:

	Conducted limit (dBµV)	
Frequency of emission (MHz)	Quasi-peak	Average
0.15–0.5	66 to 56*	56 to 46*
0.5–5	56	46
5–30	60	50

*Decreases with the logarithm of the frequency.

Procedures:

- 1. All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR and Average detectors, are reported. All other emissions were relatively insignificant.
- 2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.

3. <u>Conducted Emissions Measurement Uncertainty</u> All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 9kHz – 30MHz (Average & Quasi-peak) is ±3.5dB.

4.	Environmental Conditions	Temperature	28°C
		Relative Humidity	50%
		Atmospheric Pressure	1019mbar
	Test Date : September 22 - 26, 2008		
	Tested By : Snell Leong		

Results: Pass

NOTE: Applicant Stated that the MultiCLASS Model: RP40N-6408-300 is representative of testing the RP40D-6408-300 because:

1) The RP40 models have a larger 13.56MHz Antenna

2) The RP40 models have the same 125kHz transmit section and antenna

3) The amount of energy coupled to the input of the AC/DC power supply is directly proportional to the B-field antenna size

Given this Model: RP40D-6408-300 was tested as the worst case model without terminating either antenna



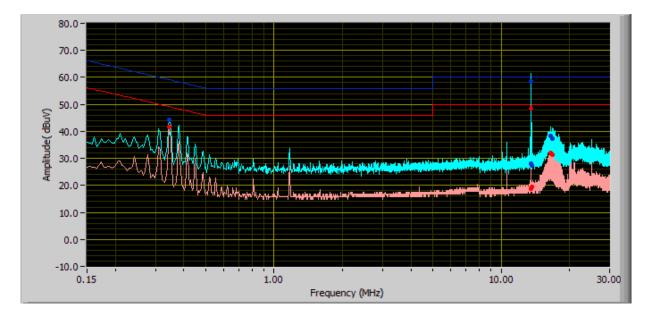
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AC Line



Quasi-Peak Limit

Average Limit

Frequency (MHz)	QP Value (dBµV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Avg Value (dBµV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Line
13.56	59.43	60.00	PASS	-0.57	49.09	50.00	PASS	-0.91	Phase
0.35	44.28	59.11	PASS	-14.83	41.47	49.11	PASS	-7.64	Phase
13.49	27.98	60.00	PASS	-32.02	18.68	50.00	PASS	-31.32	Phase
13.64	27.49	60.00	PASS	-32.51	19.40	50.00	PASS	-30.60	Phase
16.56	38.24	60.00	PASS	-21.76	32.06	50.00	PASS	-17.94	Phase
16.76	37.35	60.00	PASS	-22.65	31.24	50.00	PASS	-18.76	Phase

Phase Line Plot at 120Vac, 60Hz

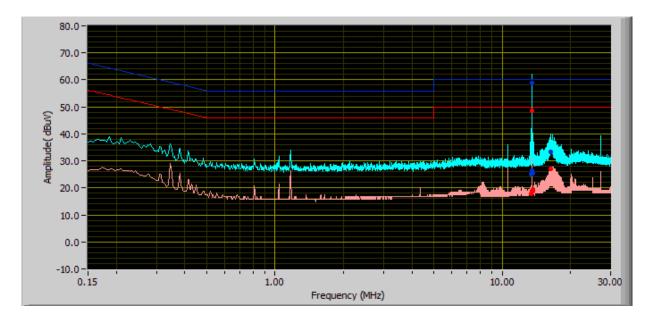


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Quasi-Peak Limit

Average Limit

Frequency (MHz)	QP Value (dBµV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Avg Value (dBµV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Line
13.56	59.43	60.00	PASS	-0.88	48.43	50.00	PASS	-1.57	Neutral
0.35	44.28	59.11	PASS	-33.65	18.68	50.00	PASS	-31.32	Neutral
13.49	27.98	60.00	PASS	-34.95	17.92	50.00	PASS	-32.08	Neutral
13.64	27.49	60.00	PASS	-34.25	18.70	50.00	PASS	-31.30	Neutral
16.56	38.24	60.00	PASS	-26.76	27.08	50.00	PASS	-22.92	Neutral
16.76	37.35	60.00	PASS	-34.57	19.40	50.00	PASS	-30.60	Neutral

Neutral Line Plot at 120Vac, 60Hz



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5.3 Radiated Emission < 30MHz (9kHz - 30MHz, H-Field)

Requirement(s): 47 CFR §15.225 & RSS-210 (A2.6) & RSS-310 (3.7)

Procedures: For < 30MHz, Radiated emissions were measured according to ANSI C63.4. The EUT was set to transmit at the highest output power. The EUT was set 10 meter away from the measuring antenna. The loop antenna was positioned 1 meter above the ground from the centre of the loop. The measuring bandwidth was set to 10 kHz. (Note: During testing the receive antenna was rotated about its axis to maximize the emission from the EUT.)

The limit is converted from microvolt/meter to decibel microvolt/meter.

Sample Calculation: Corrected Amplitude = Raw Amplitude $(dB\mu V/m) + ACF (dB) + Cable Loss(dB) - Distance Correction Factor$

Results: Pass



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(Frequency: 125 kHz)

		-			-		-			
Frequency	Raw Amplitude @ 3m	Measure	Ant. Height	Ant. Factor	Cable Loss	Pre Amp Gain	Distance Correction Factor	Corrected Amplitude @ 300m	Limits @ 300m	Margin
(MHz)	(dBµV/m)	(Avg/QP)	(m)	(dB)	(dB)	(dBm)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
0.125	20.60	Peak	1.00	66.90	0.00	28.40	80.00	-20.90	25.67	-46.57

Loop Antenna Positioned at 0 degrees, Azimuth 0 degrees with RFID activated

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Loop Antenna Positioned at 90 degrees, Azimuth 90 degrees with RFID activated

Frequency	Raw Amplitude @ 3m	Measure	Ant. Height	Ant. Factor	Cable Loss	Pre Amp Gain	Distance Correction Factor	Corrected Amplitude @ 300m	Limits @ 300m	Margin
(MHz)	(dBµV/m)	(Avg/QP)	(m)	(dB)	(dB)	(dBm)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
0.125	18.50	Peak	1.50	66.90	0.00	28.40	80.00	-23.00	25.67	-48.67

Table 2

(Frequency: 13.56 MHz)

Loop Antenna Positioned at 0 degrees, Azimuth 0 degrees with RFID activated

Frequency	Raw Amplitude @ 10m	Measure	Ant. Height	Ant. Factor	Cable Loss	Pre Amp Gain	Distance Correction Factor	Corrected Amplitude @ 30m	Limits Part 15.209 & Part 15.225	Margin
(MHz)	(dBµV/m)	(Avg/QP)	(m)	(dB)	(dB)	(dBm)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
13.56	48.80	Peak	1.00	35.40	0.30	27.20	20.92	15.46	84.00	-68.54
27.12	18.50	Peak	1.00	34.20	0.30	27.20	20.92	-16.04	29.54	-45.58

Table 3

Loop Antenna Positioned at 90 degrees, Azimuth 90 degrees with RFID activated

Frequency	Raw Amplitude @ 10m	Measure	Ant. Height	Ant. Factor	Cable Loss	Pre Amp Gain	Distance Correction Factor	Corrected Amplitude @ 30m	Limits Part 15.209 & Part 15.225	Margin
(MHz)	(dBµV/m)	(Avg/QP)	(m)	(dB)	(dB)	(dBm)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
13.56	55.70	Peak	1.00	35.40	0.30	27.20	20.92	22.36	84.00	-61.64
27.12	16.70	Peak	1.00	34.20	0.30	27.20	20.92	-17.84	29.54	-47.38



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5.4 Radiated Emissions > 30 MHz (30MHz - 1 GHz, E-Field)

Requirement(s): 47 CFR §15.209; 47 CFR §15.225(d) & RSS-210 (A2.6)

Procedures: For > 30MHz, Radiated emissions were measured according to ANSI C63.4. The EUT was set to transmit at the highest output power. The EUT was set 10 meter away from the measuring antenna. The Log periodic antenna was positioned 1 meter above the ground from the centre of the antenna. The measuring bandwidth was set to 120 kHz. (Note: During testing the receive antenna was raise from 1~4 meters to maximize the emission from the EUT.)

The limit is converted from microvolt/meter to decibel microvolt/meter.

Sample Calculation: Corrected Amplitude = Raw Amplitude $(dB\mu V/m) + ACF (dB) + Cable Loss(dB) - Distance Correction Factor$

Results: Pass



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Frequency	Raw Amplitude @ 10m (QP)	Azimuth	Ant. Height	Ant. Polarity	Ant. Factor	Cable Loss	Pre Amp Gain	Corrected Amplitude @ 10m	Limit @10m	Margin
(MHz)	(dBµV/m)	(Degrees)	(m)	(H/V)	(dB)	(dB)	(dBm)	(dBµV/m)	(dBµV/m)	(dBµV/m)
40.68	30.80	180.00	3.00	Н	12.63	0.30	27.10	16.63	29.54	-12.91
40.68	33.90	258.00	1.00	V	12.63	0.30	27.10	19.73	29.54	-9.81
433.93	39.90	191.00	2.68	Н	16.60	2.10	26.60	32.00	35.54	-3.54
433.93	35.23	88.00	1.00	V	16.60	2.10	26.60	27.33	35.54	-8.21
406.81	41.80	195.00	2.75	Н	16.04	2.10	26.60	33.34	35.54	-2.21
406.81	36.20	80.00	1.00	V	16.04	2.10	26.60	27.74	35.54	-7.81
379.69	35.50	40.00	2.60	Н	15.51	1.70	26.60	26.11	35.54	-9.43
379.69	30.90	61.00	1.00	V	15.51	1.70	26.60	21.51	35.54	-14.03
325.45	30.90	316.00	3.30	Н	14.21	1.70	26.60	20.21	35.54	-15.34
325.45	31.60	256.00	1.00	V	14.21	1.70	26.60	20.91	35.54	-14.64
352.57	33.30	210.00	2.62	Н	14.85	1.70	26.60	23.25	35.54	-12.29
352.57	27.70	277.00	1.00	V	14.85	1.70	26.60	17.65	35.54	-17.89
54.24	36.30	320.00	3.50	Н	7.20	0.50	26.70	17.30	29.54	-12.24
54.24	38.50	83.00	1.00	V	7.20	0.50	26.70	19.50	29.54	-10.04

Table 5



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5.5 Frequency Stability

Requirement(s): 47 CFR §15.225(e) & RSS-210 (A2.6)

Procedures: Frequency Stability was measured according to 47 CFR §2.1055. Measurement was taken with spectrum analyzer. The spectrum analyzer bandwidth and span was set to read in hertz. A voltmeter was used to monitor when varying the voltage.

Limit: $\pm 0.01\%$ of 13.56 MHz = 1356 Hz, $\pm 0.01\%$ of 125 kHz = 125 Hz

Results: Pass

NOTE: Applicant stated that the MultiCLASS Model: RP40N-6408-300 was tested as the representative sample for the following reasons:

1) The 13.56 MHz RF section is electrically identical in all iCLASS and MultiCLASS Models accept for antenna size which has no baring on this requirement

2) The 125 kHz RF Transmit section is schematically identical in all MultiCLASS Models. The minor change in layout has no baring on this requirement

Given this Model: RP40N-6408-300 was tested as the representative Model for all iCLASS and MultiCLASS Models

Frequency Stability versus Temperature: The Frequency tolerance of the carrier signal shall be maintained within $\pm 0.01\%$ of the operating frequency over a temperature variation of -20°C to +50°C at normal supply voltage.

Temperature (ºC)	Measured Freq. (MHz)	Freq. Drift (Hz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
50	125.033	8	<0.01	Pass
20		Reference		
-20	125.048	23	<0.01	Pass

Reference Frequency: 125.025 kHz at -20°C and +50°C

Table 6

Frequency Stability versus Input Voltage: The Frequency tolerance of the carrier signal shall be maintained within $\pm 0.01\%$, the frequency of the transmitter was measured at 85% and at 115% of the rated power supply voltage at 20°C environmental temperature.

Measured Voltage ±15% of nominal (DC)	Measured Freq. (MHz)	Freq. Drift (Hz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
10.2	125.028	3.0	<0.01	Pass
13.8	125.030	5.0	<0.01	Pass

Carrier Frequency: 125.025 kHz at 20°C at 12VDC



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Frequency Stability versus Temperature: The Frequency tolerance of the carrier signal shall be maintained within $\pm 0.01\%$ of the operating frequency over a temperature variation of -20°C to +50°C at normal supply voltage.

Temperature (ºC)	Measured Freq. (MHz)	Freq. Drift (Hz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
50	13.56048	110	<0.01	Pass
40	13.56052	150	<0.01	Pass
30	13.56068	310	<0.01	Pass
20		Reference		
10	13.56086	490	<0.01	Pass
0	13.56086	490	<0.01	Pass
-10	13.56093	560	<0.01	Pass
-20	13.56096	590	<0.01	Pass

Reference Frequency: 13.56037 MHz at -20°C and +50°C

Table 8

Frequency Stability versus Input Voltage: The Frequency tolerance of the carrier signal shall be maintained within $\pm 0.01\%$, the frequency of the transmitter was measured at 85% and at 115% of the rated power supply voltage at 20°C environmental temperature.

Carrier Frequency: 13.56037 MHz at 20°C at 12VDC

Measured Voltage ±15% of nominal (DC)	Measured Freq. (MHz)	Freq. Drift (Hz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
10.2	13.56038	10	<0.01	Pass
13.8	13.56040	30	<0.01	Pass

Table 9



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5.6 Occupied Bandwidth

Requirement(s): RSS-210 (5.9.1)

Procedures: Occupied Bandwidth was measured according to RSS-210 (5.9.1). Measurement was taken with spectrum analyzer. The spectrum analyzer bandwidth and span was set to read in hertz.

Results: Pass

NOTE: Applicant stated that the MultiCLASS Model: RP40N-6408-300 was tested as the representative sample for the following reasons:

1) The 13.56 MHz RF section is electrically identical in all iCLASS and MultiCLASS Models accept for antenna size which has no baring on this requirement

2) The 125 kHz RF Transmit section is schematically identical in all MultiCLASS Models. The minor change in layout has no baring on this requirement

Given this Model: RP40N-6408-300 was tested as the representative Model for all iCLASS and MultiCLASS Models



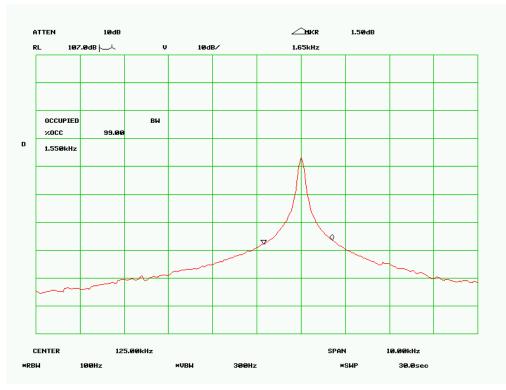
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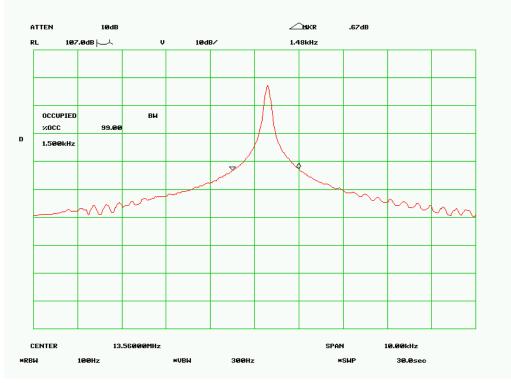
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Plots: 13.56 MHz



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Annex A. TEST INSTRUMENT & METHOD

Annex A.i. TEST INSTRUMENTATION & GENERAL PROCEDURES

Instrument	Model	Serial #	Calibration Due
Conducted Emissions			
R & S Receiver	ESIB 40	100179	04/25/2009
R&S LISN	ESH2-Z5	861741/013	04/27/2009
CHASE LISN	MN2050B	1018	04/26/2009
Radiated Emissions			
R & S Receiver	ESIB 40	100179	04/25/2009
Sunol Sciences, Inc. antenna (30MHz~2GHz)	JB1	A030702	01/04/2009
ETS-Lingren Loop Antenna	6512	00049120	05/13/2009
DMM	Fluke	73111	05/01/2009
Variac	KRM	AEEC-2090	See Note
Environment Chamber	Test Equity	1007H	01/24/2009

Note: Functional Verification



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Annex A.ii. CONDUCTED EMISSIONS TEST DESCRIPTION

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m x 1m x 0.8m high, non-metallic table, as shown in <u>Annex B</u>.
- 2. The power supply for the EUT was fed through a $50\Omega/50\mu$ H EUT LISN, connected to filtered mains.
- 3. The RF OUT of the EUT LISN was connected to the EMI test receiver via a low-loss coaxial cable.
- 4. All other supporting equipments were powered separately from another main supply.

Test Method

- 1. The EUT was switched on and allowed to warm up to its normal operating condition.
- 2. A scan was made on the NEUTRAL line (for AC mains) or Earth line (for DC power) over the required frequency range using an EMI test receiver.
- 3. High peaks, relative to the limit line, were then selected.
- 4. The EMI test receiver was then tuned to the selected frequencies and the necessary measurements made with a receiver bandwidth setting of 10 KHz. For FCC tests, only Quasi-peak measurements were made; while for CISPR/EN tests, both Quasi-peak and Average measurements were made.
- 5. Steps 2 to 4 were then repeated for the LIVE line (for AC mains) or DC line (for DC power).

Sample Calculation Example

At 20 MHz	limit = 250 μ V = 47.96 dB μ V		
Transducer factor of LISN, pulse limiter & cable loss at 20 MHz = 11.20 dB			
Q-P reading obtained directly from EMI Receiver = $40.00 \text{ dB}\mu\text{V}$ (Calibrated for system losses)			
Therefore, Q-P margin = 47.96 – 40.00 = 7.96	i.e. 7.96 dB below limit		



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Annex A. iii RADIATED EMISSIONS TEST DESCRIPTION

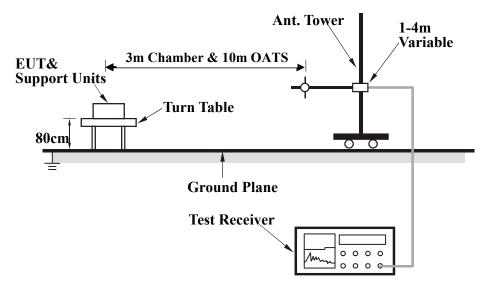
EUT Characterisation

EUT characterisation, over the frequency range from 100kHz – 1GHz to 10th Harmonic, was done in order to minimise radiated emissions testing time while still maintaining high confidence in the test results.

The EUT was placed in the chamber, at a height of about 0.8m on a turntable. Its radiated emissions frequency profile was observed, using a spectrum analyzer /receiver with the appropriate broadband antenna placed 3m away from the EUT. Radiated emissions from the EUT were maximised by rotating the turntable manually, changing the antenna polarisation and manipulating the EUT cables while observing the frequency profile on the spectrum analyzer / receiver. Frequency points at which maximum emissions occurred; clock frequencies and operating frequencies were then noted for the formal radiated emissions test at the Open Area Test Site (OATS) at 10m distance.

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m X 1.0m X 0.8m high, non-metallic table.
- 2. The filtered power supply for the EUT and supporting equipment were tapped from the appropriate power sockets located on the turntable.
- 3. The relevant broadband antenna was set at the required test distance away from the EUT and supporting equipment boundary.





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Test Method

The following procedure was performed to determine the maximum emission axis of EUT:

1. With the receiving antenna is H polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.

2. With the receiving antenna is V polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.

3. Compare the results derived from above two steps. So, the axis of maximum emission from EUT was determined and the configuration was used to perform the final measurement.

Final Radiated Emission Measurement

1. Setup the configuration according to figure 1. Turn on EUT and make sure that it is in normal function.

2. For emission frequencies measured below 1 GHz, a pre-scan is performed in a shielded chamber to determine the accurate frequencies of higher emissions will be checked on a open test site. As the same purpose, for emission frequencies measured above 1 GHz, a pre-scan also be performed with a 1 meter measuring distance before final test.

3. For emission frequencies measured below 1 GHz, set the spectrum analyzer on a 100 kHz and 1 MHz resolution bandwidth respectively for each frequency measured in step 2.

4. The search antenna is to be raised and lowered over a range from 1 to 4 meters in horizontally polarized orientation. Position the highness when the highest value is indicated on spectrum analyzer, then change the orientation of EUT on test table over a range from 0 ° to 360 ° with a speed as slow as possible, and keep the azimuth that highest emission is indicated on the spectrum analyzer. Vary the antenna position again and record the highest value as a final reading.

5. Repeat step 4 until all frequencies need to be measured were complete.

6. Repeat step 5 with search antenna in vertical polarized orientations.

During the radiated emission test, the Spectrum Analyzer was set with the following configurations:

Frequency Band	(MHz) Funct	ion Resolution ban	dwidth Video Bandwidth
30 to 1000	Pea	k 100 kHz	100 kHz
Above 1000	Pea	k 1 MHz	1 MHz
	Avera	ge 1 MHz	10 Hz

Sample Calculation Example

The field strength is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain (if any) from the measured reading. For the limit is employed average value, therefore the peak value can be transferred to average value by subtracting the duty factor. The basic equation with a sample calculation is as follows:

Peak = Reading + Corrected Factor

where

Corr. Factor = Antenna Factor + Cable Factor - Amplifier Gain (if any) And the average value is

Average = Peak Value + Duty Factor or Set RBW = 1MHz, VBW = 10Hz.

Note :

If the measured frequencies are fall in the restricted frequency band, the limit employed must be quasi peak value when frequencies are below or equal to 1 GHz. And the measuring instrument is set to quasi peak detector function.

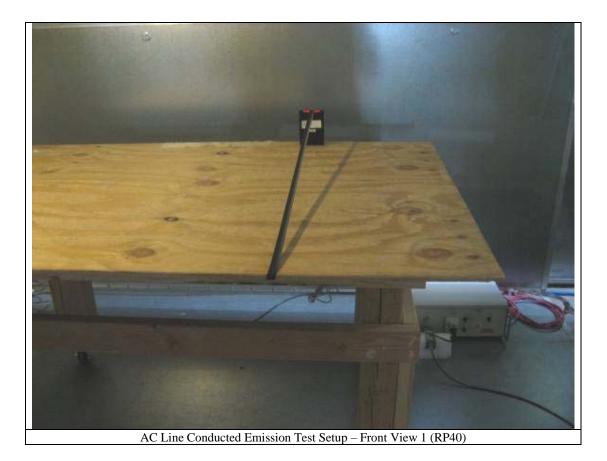


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TEST SETUP PHOTOGRAPHS Annex B.





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50 Radiated Emission Test Setup - Front View (<30MHz)

Radiated Emission Test Setup - Rear View (<30MHz)



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n Radiated Emission Test Setup – Front View (>30MHz) · •

Radiated Emission Test Setup – Rear View (>30MHz)



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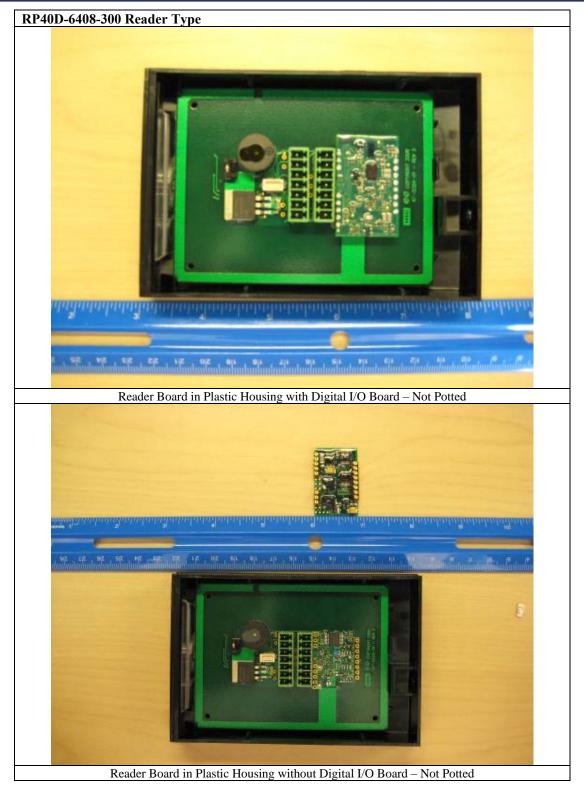
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Annex B. i. EUT INTERNAL PHOTOGRAPHS





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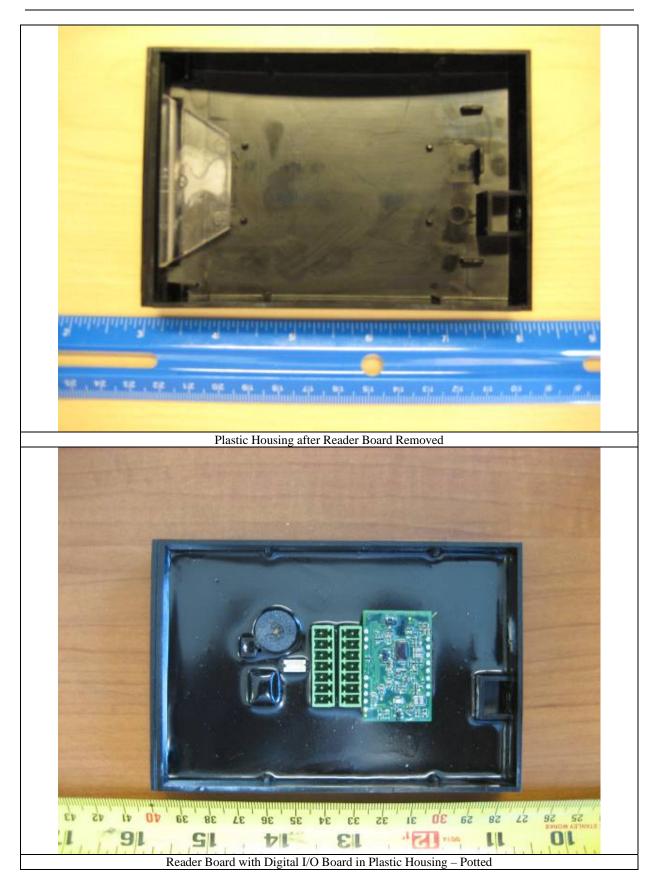
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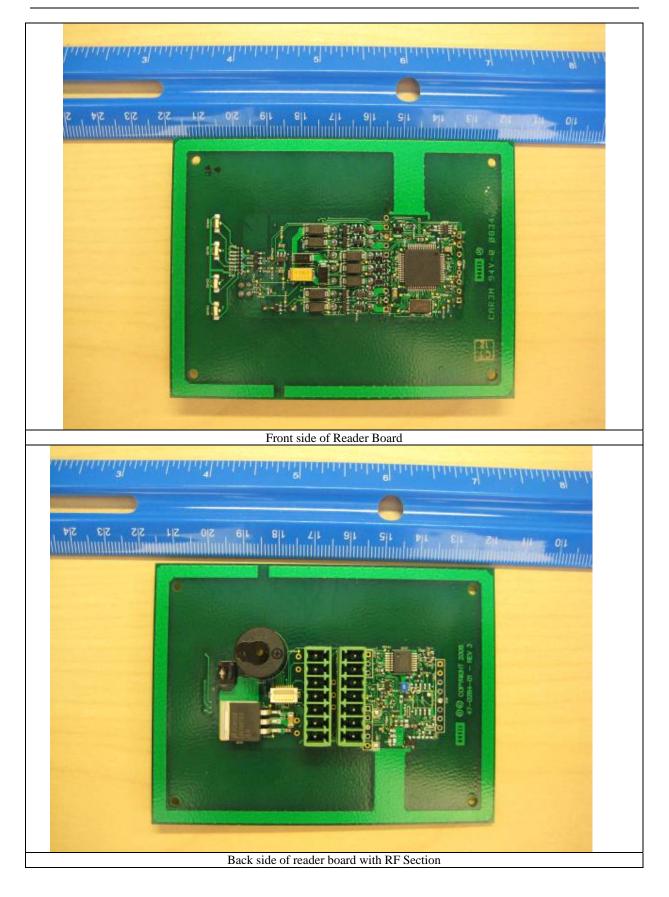
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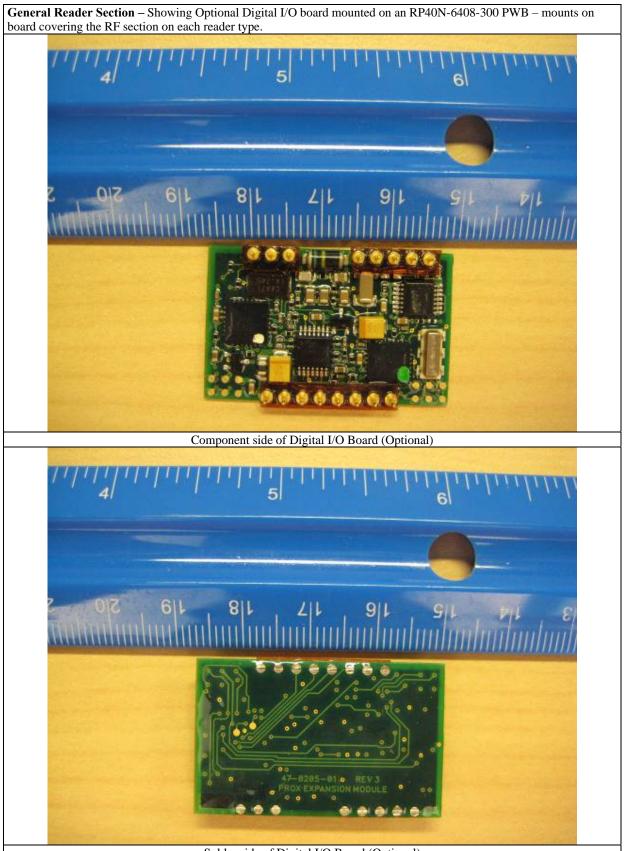


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Solder side of Digital I/O Board (Optional)



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Annex B. ii. EUT EXTERNAL PHOTOGRAPHS





То

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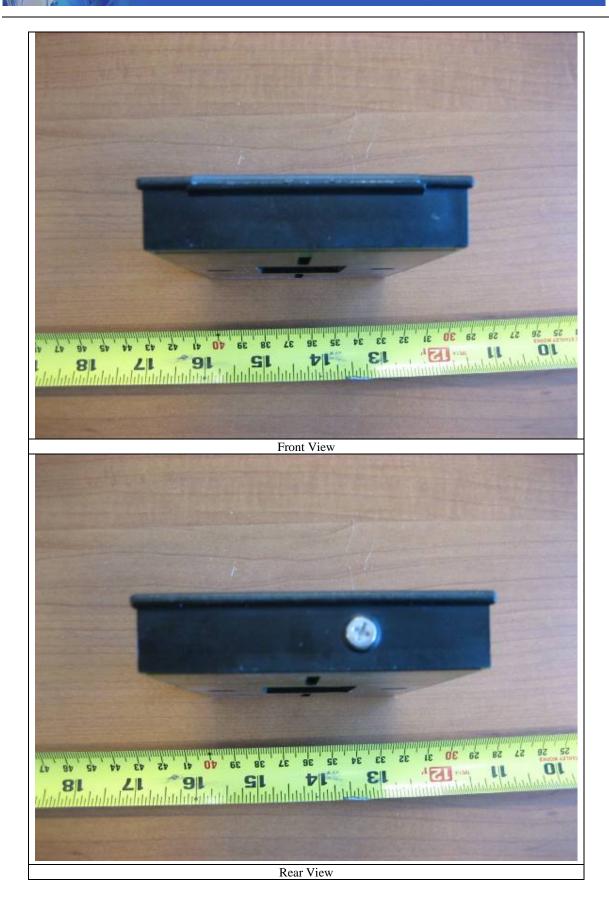
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Annex C. SUPPORTING EQUIPMENT DESCRIPTION

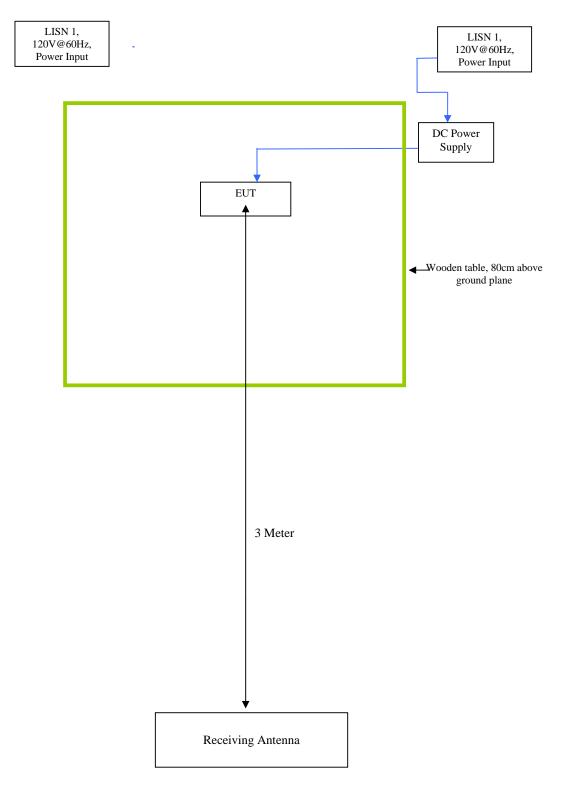
The following is a description of supporting equipment and details of cables used with the EUT.

Equipment Description (Including Brand Name)	Model & Serial Number	Cable Description (List Length, Type & Purpose)
Topward Electric Instrument Co., Ltd. Linear AC/DC Power Supply	Model: TPS-2000 SN: 920035	N/A

NOTE: No special supporting equipment are used or needed during testing to achieve compliance.

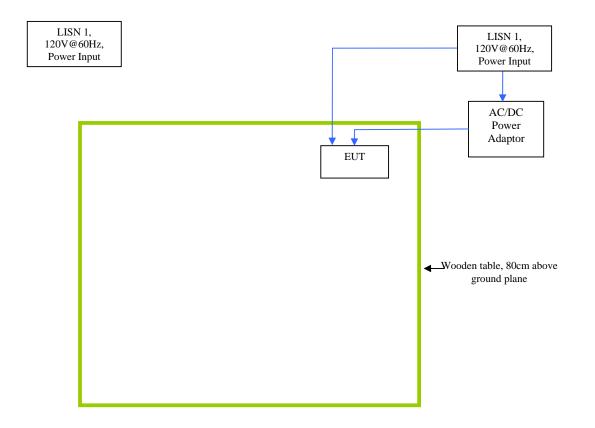


Block Configuration Diagram for Radiated Emission





Block Configuration Diagram for Conducted Emission



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Annex C. EUT OPERATING CONDITIONS

The following is the description of how the EUT is exercised during testing.

Test	Description Of Operation	
Emissions Testing	The EUT was controlled by itself.	
Others Testing	The EUT was controlled by itself.	



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Annex D USER MANUAL, BLOCK & CIRCUIT DIAGRAM

Please see attachment